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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/722,652	11/26/2003	Kerry Leeds Davison	4-7-23	7648
7590 11/13/2007 Ryan, Mason & Lewis, LLP 90 Forest Avenue			EXAMINER	
			NGO, HUNG V	
Locust Valley, NY 11560			ART UNIT	PAPER NUMBER
			2831	
			MAIL DATE	DELIVERY MODE
			11/13/2007	PAPER

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

	Application No.	Applicant(s)				
	10/722,652	DAVISON ET AL.				
Office Action Summary	Examiner	Art Unit				
·	Hung V. Ngo	2831				
The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply						
A SHORTENED STATUTORY PERIOD FOR RE WHICHEVER IS LONGER, FROM THE MAILING - Extensions of time may be available under the provisions of 37 CF after SIX (6) MONTHS from the mailing date of this communication - If NO period for reply is specified above, the maximum statutory pe - Failure to reply within the set or extended period for reply will, by si Any reply received by the Office later than three months after the m earned patent term adjustment. See 37 CFR 1.704(b).	G DATE OF THIS COMMUNICA R 1.136(a). In no event, however, may a rep h. eriod will apply and will expire SIX (6) MONTH tatute, cause the application to become ABAN	ATION. y be timely filed S from the mailing date of this communication. IDONED (35 U.S.C. § 133).				
Status						
Responsive to communication(s) filed on _ This action is FINAL . 2b) □ 3) □ Since this application is in condition for all closed in accordance with the practice und	This action is non-final. owance except for formal matter					
Disposition of Claims						
4) ⊠ Claim(s) 1-9,11,13-18 and 20 is/are pendir 4a) Of the above claim(s) is/are with 5) □ Claim(s) is/are allowed. 6) ⊠ Claim(s) 1-9,11,13-18 and 20 is/are rejected. 7) □ Claim(s) is/are objected to. 8) □ Claim(s) are subject to restriction are	drawn from consideration.					
Application Papers						
9) The specification is objected to by the Exam 10) The drawing(s) filed on is/are: a) Applicant may not request that any objection to Replacement drawing sheet(s) including the co 11) The oath or declaration is objected to by the	accepted or b) objected to by the drawing(s) be held in abeyance rrection is required if the drawing(s)	e. See 37 CFR 1.85(a). is objected to. See 37 CFR 1.121(d).				
Priority under 35 U.S.C. § 119						
 12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of: 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No. 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received. 						
Attachment(s) 1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948)		nmary (PTO-413) Mail Date				
Notice of Draftsperson's Patent Drawing Review (PTO-946) Information Disclosure Statement(s) (PTO/SB/08) Solution						

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The Board of Patent Appeals and Interferences affirmed the rejection(s) against

DETAILED ACTION

independent claim(s) 19, but reversed all rejections against claim(s) 1-8, 14, 15, 17, 18,

20. The independent claim(s) 19 is/are cancelled by the examiner in accordance with

MPEP § 1214.06.

In view of the decision on appeal on 08-31-07 on, PROSECUTION IS HEREBY

REOPENED.

To avoid abandonment of the application, appellant must exercise one of the

following two options:

(1) file a reply under 37 CFR 1.111 (if this Office action is non-final) or a reply

under 37 CFR 1.113 (if this Office action is final); or,

(2) initiate a new appeal by filing a notice of appeal under 37 CFR 41.31 followed

by an appeal brief under 37 CFR 41.37. The previously paid notice of appeal fee and

appeal brief fee can be applied to the new appeal. If, however, the appeal fees set forth

in 37 CFR 41.20 have been increased since they were previously paid, then appellant

must pay the difference between the increased fees and the amount previously paid.

A Supervisory Patent Examiner (SPE) has approved of reopening prosecution by

signing below:

Diego Gutierrez Supervisory Patent Examiner

Technology Center 2800

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Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.

Claims 1-9, 11, 13-18, 20 are rejected under 35 U.S.C. 102(e) as being anticipated by Wu (US 6,770,963).

Re claim 1, Wu discloses an integrated circuit device comprising:

a die (202) having a top surface with a peripheral region (203) and an interior region surrounded by the peripheral region (Fig 2):

a plurality of bond pads (221, 231, 241) disposed in the peripheral region of the die; at least one internal bus (204, 206, 208), disposed in the interior region of the die, that distributes power to a plurality of internal node points of the die; and at least one bond wire connecting at least one of the plurality of bond pads with the at least one internal bus (Fig 2).

Re claim 2, wherein the at least one internal bus comprises a metal power grid (col. 9, lines 35-40).

Re claim 3, wherein the at least one internal bus comprises at least one internal positive voltage supply bus (col. 9, lines 35-40).

Re claim 4. The integrated circuit device of claim 1, wherein the at least one internal bus

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comprises at least one internal negative voltage supply bus (col. 8, lines 15-20)(abstract).

Re claim 5, wherein the at least one internal bus comprises at least one pair of buses comprising an internal positive voltage supply bus and internal negative voltage supply bus (col. 9, lines 35-40), (col. 8, lines 15-20).

Re claim 6, wherein at least one of the voltage supply buses comprises a ground bus (col. 8, lines 15-20) (abstract).

Re claim 7, wherein the at least one internal bus comprises bond pads having active circuitry (integrated circuit in the die 202) disposed thereunder.

Re claim 8, wherein at least one of the plurality of bond pads is wire bonded to an integrated circuit package (100),(Fig 2).

Re claim 9, wherein the at least one of the plurality of bond pads wire bonded to the at least one internal bus is also wire bonded via another bond wire to a positive voltage supply terminal (106) of the device.

Re claim 11, wherein the at least one of the plurality of bond pads wire bonded to the at least one internal bus is also wire bonded via another bond wire to a negative voltage supply terminal (106) of the device (Fig 2).

Re claim 13, wherein the at least one of the plurality of bond pads wire bonded to the at least one internal bus is connected to another of the plurality of bond pads (Fig 2).

Re claim 14, further comprising local power interconnects that distribute power from the at least one internal bus to the plurality of internal node points (Fig 2).

Re claim 15, wherein the plurality of internal node points comprise circuit elements (Fig

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2).

Re claim 16, wherein the power is distributed from the at least one of the plurality of bond pads to at least one secondary bond pad (106) through a metal connector (114, 116), and from the at least one secondary bond pad to the at least one internal bus through at least one wire bond connection within the peripheral region of the die (Fig 2). Re claim 17, wherein the at least one of the plurality of bond pads comprises at least one pair of bond pads comprising a positive voltage supply bond pad and a negative voltage supply bond pad (abstract).

Re claim 18, wherein the at least one pair of bond pads comprises at least about twelve pairs of bond pads substantially evenly spaced apart in the peripheral region of the die (Fig 2).

Re claim 20, Wu disclose a method of constructing an integrated circuit device comprising the following steps: forming an integrated circuit die (202) having at least one peripheral bond pad (221, 231, 241) and at least one internal bus (204, 206, 208), the internal bus being configured for distributing power to a plurality of internal node points of the integrated circuit device (Fig 2); and wire bonding the at least one peripheral bond pad to the at least one internal bus (Fig 2).

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Hung V. Ngo whose telephone number is (571) 272-1979. The examiner can normally be reached on Monday to Thursday 8:30-6:00.

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Diego Gutierrez can be reached on (571) 272-2800 EXT 31. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

HVN

11-06-07

Hnng V Na

HUNG V. NGO PRIMARY EXAMINER